Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/584,864	Reexamination LEONE ET AL.	
Examiner	Art Unit	
SHIN-HON CHEN	2431	Page 1 of 1

U.S. PATENT DOCUMENTS

U.G. TATENT DOGGMENTO					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,690,930	02-2004	Dupre , Michael	455/411
*	В	US-5,534,857	07-1996	Laing et al.	340/5.74
*	С	US-2005/0021940	01-2005	Ma, Kenneth	713/155
*	D	US-7,177,425	02-2007	Ben-Chuan et al.	380/44
*	Е	US-2005/0037752	02-2005	Kwan et al.	455/432.3
*	F	US-2004/0024846	02-2004	Randall et al.	709/219
*	G	US-6,504,932	01-2003	Vasnier et al.	380/273
*	Н	US-2004/0204124	10-2004	Campbell, Lowell Lete	455/566
*	_	US-2004/0210766	10-2004	Kroselberg, Dirk	713/201
*	J	US-6,591,364	07-2003	Patel, Sarvar	713/170
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

NON-PATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	х				

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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